LLL/LLR/LLA/LLM Series Specifications and Test Methods (2)

| No. | Item | | Specifications | Test Method |
|-----|---|------------------------|---|--|
| 1 | Operating Temperature Range | | R6: -55 to +85°C R7, C7: -55 to +125°C C8: -55 to +105°C | |
| 2 | Rated Voltage | | See the previous pages. | The rated voltage is defined as the maximum voltage that may be applied continuously to the capacitor. When AC voltage is superimposed on DC voltage, V ^{P,P} or V ^{O,P} , whichever is larger, should be maintained within the rated voltage range. |
| 3 | Appearance | | No defects or abnormalities | Visual inspection |
| 4 | Dimensions | | Within the specified dimension | Using calipers |
| 5 | Dielectric Strength | | No defects or abnormalities | No failure should be observed when 250% of the rated voltage is applied between the terminations for 1 to 5 seconds, provided the charge/discharge current is less than 50mA. |
| 6 | Insulation Resistance | | 50Ω · F min. | The insulation resistance should be measured with a DC voltage not exceeding the rated voltage at 25°C and 75%RH max. and within 1 minute of charging. |
| 7 | Capacitance | | Within the specified tolerance | The capacitance/D.F. should be measured at 25°C at the frequency and voltage shown in the table. |
| 8 | Dissipatio (D.F.) | on Factor | R6, R7, C7, C8: 0.120 max. | Capacitance Frequency Voltage C≤10μF (10V min.) 1±0.1kHz 1.0±0.2Vrms C≤10μF (6.3V max.) 1±0.1kHz 0.5±0.1Vrms C>10μF 120±24Hz 0.5±0.1Vrms |
| 9 | Capacitance Temperature Characteristics | | Char. Temp. Range (°C) Reference Temp. Cap. Change R6 -55 to +85 Within ±15% R7 -55 to +125 Within ±15% C7 -55 to +125 Within ±22% C8 -55 to +105 Within ±22% | The capacitance change should be measured after 5 min. at each specified temperature stage. The ranges of capacitance change compared with the 25°C value over the temperature ranges shown in the table should be within the specified ranges. Measuring voltage: LLL153C70E105; 0.2±0.05Vrms Initial measurement. Perform a heat treatment at 150+0/-10°C for one hour and then set for 24±2 hours at room temperature. Perform the initial measurement. |
| 10 | Adhesive Strength of Termination | | No removal of the terminations or other defect should occur. | Solder the capacitor to the test jig (glass epoxy board) using a eutectic solder. Then apply 10N* force in parallel with the test jig for 10±1 sec. The soldering should be done either with an iron or using the reflow method and should be conducted with care so that the soldering is uniform and free of defects such as heat shock. *5N (LLL15, LLL18, LLR18, LLA, LLM Series) |
| | Vibration | Appearance | No defects or abnormalities | Solder the capacitor to the test jig (glass epoxy board) in the same manner and under the same conditions as (10). The capacitor should be subjected to a simple harmonic motion having a total amplitude of 1.5mm, the frequency being varied uniformly between the approximate limits of 10 and 55Hz. The frequency range, from 10 to 55Hz and return to 10Hz, should be traversed in approximately 1 minute. This motion should be applied for a period of 2 hours in each of 3 mutually perpendicular directions (total of 6 hours). |
| | | Capacitance | Within the specified tolerance | |
| 11 | | D.F. | R6, R7, C7, C8: 0.120 max. | |
| 12 | Solderability of Termination | | 75% of the terminations are to be soldered evenly and continuously. | Immerse the capacitor in a solution of ethanol (JIS-K-8101) and rosin (JIS-K-5902) (25% rosin in weight proportion). Preheat at 80 to 120°C for 10 to 30 seconds. After preheating, immerse in eutectic solder solution for 2±0.5 seconds at 230±5°C, or Sn-3.0Ag-0.5Cu solder solution for 2±0.5 seconds at 245±5°C. |
| | | Appearance | No marking defects | Preheat the capacitor at 120 to 150°C for 1 minute. Immerse |
| | Resistance to Soldering Heat | Capacitance Change | R6, R7, C7, C8: Within ±7.5% | the capacitor in a eutectic solder or Sn-3.0Ag-0.5Cu solder solution at 270±5°C for 10±0.5 seconds. Let sit at room temperature for 24±2 hours, then measure. • Initial measurement. Perform a heat treatment at 150+0/–10°C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement. |
| 13 | | D.F. | R6, R7, C7, C8: 0.120 max. | |
| | | I.R. | $50\Omega \cdot F$ min. | |
| | | Dielectric Strength | No failure | |

Continued on the following page.



Note 1. This Specifications and Test Methods is downloaded from the website of Murata Manufacturing co.,ltd. Therefore, it's specifications are subject to change or our products in it may be discontinued without advance notice. Please check with our sales representatives or product engineers before ordering.

2. This Specifications and Test Methods has only typical specifications because there is no space for detailed specifications. Therefore, please approve our product specifications or transact the approval sheet for product specifications before ordering.

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Continued from the preceding page.

| No. | . Item | | Specifications | Test Method |
|---------|--|-------------------------------------|--|---|
| 14 | Temperature Sudden Change | Appearance Capacitance Change | No marking defects R6, R7, C7, C8: Within ±12.5% | Fix the capacitor to the supporting jig in the same manner and under the same conditions as (10).Perform the five cycles according to the four heat treatments listed in the following table. Let sit for 24±2 hours at room temperature, |
| | | D.F. | R6, R7, C7, C8: 0.120 max. | then measure. |
| | | I.R. | $50\Omega \cdot F$ min. | Step 1 2 3 4 Temp. (°C) Min. Operating Room Temp. +0/-3 Temp. Min. Operating Temp. +0/-3 Temp. Time (min.) 30±3 2 to 3 30±3 2 to 3 Initial measurement Perform a heat treatment at 150+0/-10°C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement. |
| | | Dielectric Strength | No failure | |
| 15 | High Temperature High Humidity (Steady State) | Appearance | No marking defects | Apply the rated voltage at 40±2°C and 90 to 95% humidity for 500±12 hours. The charge/discharge current is less than 50mA. Apply the rated DC voltage. |
| | | Capacitance Change | R6, R7, C7, C8: Within ±12.5% | |
| | | D.F. | R6, R7, C7, C8: 0.2 max. | , |
| | | I.R. | 12.5Ω · F min. | Initial measurement Perform a heat treatment at 150+0/–10°C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement. Measurement after test Perform a heat treatment at 150+0/–10°C for one hour and then let sit for 24±2 hours at room temperature, then measure. |
| 16 | Durability | Appearance | No marking defects | Apply 150% of the rated voltage for 1000±12 hours at the |
| | | Capacitance Change | R6, R7, C7, C8: Within ±12.5% * LLL153C70G474, LLL153C70E105: Within ±20% | maximum operating temperature ±3°C. The charge/discharge current is less than 50mA. •Initial measurement Perform a heat treatment at 150+0/–10°C for one hour and then let sit for 24±2 hours at room temperature. Perform the initial measurement. •Measurement after test Perform a heat treatment at 150+0/–10°C for one hour and then let sit for 24±2 hours at room temperature, then measure. |
| | | D.F. | R6, R7, C7, C8: 0.2 max. | |
| | | I.R. | 25Ω · F min. | |
| * 17 | ESR | | Within below ESR value at Frequency: $10\pm0.1 MHz$ $100m\Omega$: Within 70 to $130m\Omega$ $220m\Omega$: Within 154 to $286m\Omega$ $470m\Omega$: Within 329 to $611m\Omega$ $1000m\Omega$: Within 700 to $1300m\Omega$ | The ESR should be measured at room temperature with the Equivalent of HP4294A. |

^{*} LLR: This specification is only for LLR Type